

<b>Notice of References Cited</b>	Application/Control No. 10/668,999	Applicant(s)/Patent Under Reexamination YANG ET AL.	
	Examiner Karl D. Easthom	Art Unit 2832	Page 1 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0187297	09-2004	Su et al.	029/620
	B	US-2004/0113752	06-2004	Schuster, Israel	338/310
	C	US-2001/0020548	09-2001	Burgess, Larry W.	174/262
	D	US-6,542,379	04-2003	Lauffer et al.	361/793
	E	US-6,353,540	03-2002	Akiba et al.	361/794
	F	US-6,329,065	12-2001	Ishida et al.	428/472
	G	US-6,246,312	06-2001	Poole et al.	338/307
	H	US-6,288,627	09-2001	Ulmer, Kenneth R.	338/311
	I	US-6,100,787	08-2000	Huang et al.	338/204
	J	US-6,097,277	08-2000	Ginn et al.	338/320
	K	US-5,977,863	11-1999	Bloom et al.	338/320
	L	US-5,164,699	11-1992	Smith et al.	338/310
	M	US-4,300,115	11-1981	Ansell et al.	338/314

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	6-61020	03-1994	Japan	Kani	338/260
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	IBM TDB NN9310349 (10/1993) pp. 349-350 V. 36, No. 10. "Polymer Resistor Formation in Photo Via"
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/668,999	Applicant(s)/Patent Under Reexamination YANG ET AL.	
	Examiner Karl D. Easthom	Art Unit 2832	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,179,797	12-1979	Johnson, Wendell C.	29/610.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.